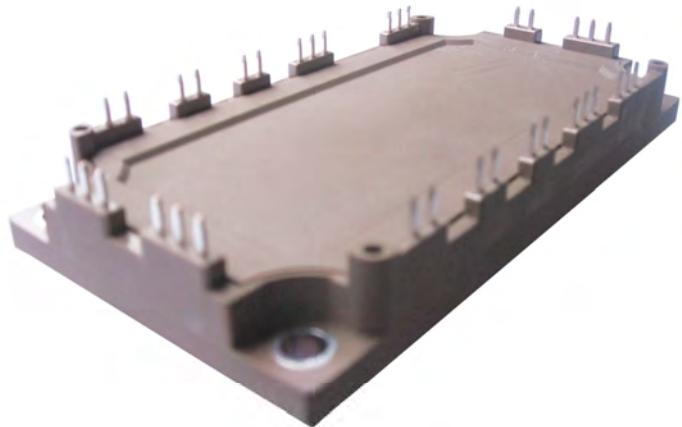


PRODUCT FEATURES

- High level of integration
- IGBT CHIP(Trench+Field Stop technology)
- Low saturation voltage and positive temperature coefficient
- Fast switching and short tail current
- Free wheeling diodes with fast and soft reverse recovery
- Industry standard package with insulated copper base plate and soldering pins for PCB mounting
- Temperature sense included



APPLICATIONS

- AC motor control
- Motion/servo control
- Inverter and power supplies

Rectifier+Brake+Inverter

IGBT-inverter

ABSOLUTE MAXIMUM RATINGS($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions	Values	Unit
V_{CES}	Collector Emitter Voltage	1200	V
V_{GES}	Gate Emitter Voltage	± 20	
I_C	DC Collector Current	150	A
		100	
I_{CM}	Repetitive Peak Collector Current	200	
P_{tot}	Power Dissipation Per IGBT	576	

Diode-inverter

ABSOLUTE MAXIMUM RATINGS($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions	Values	Unit
V_{RRM}	Repetitive Reverse Voltage	1200	V
$I_{F(AV)}$	Average Forward Current	100	
I_{FRM}	Repetitive Peak Forward Current	200	A
		3200	
I^2t		$T_J=125^\circ\text{C}, t=10\text{ms}, V_R=0\text{V}$	A^2S

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IGBT-inverter**ELECTRICAL CHARACTERISTICS ($T_C=25^\circ\text{C}$ unless otherwise specified)**

Symbol	Parameter/Test Conditions			Min.	Typ.	Max.	Unit	
$V_{GE(\text{th})}$	Gate Emitter Threshold Voltage	$V_{CE}=V_{GE}, I_C=4\text{mA}$	5.0	5.8	6.5	V		
$V_{CE(\text{sat})}$	Collector Emitter Saturation Voltage	$I_C=100\text{A}, V_{GE}=15\text{V}, T_J=25^\circ\text{C}$		1.75	2.25			
		$I_C=100\text{A}, V_{GE}=15\text{V}, T_J=125^\circ\text{C}$		2.05				
		$I_C=100\text{A}, V_{GE}=15\text{V}, T_J=150^\circ\text{C}$		2.1				
I_{CES}	Collector Leakage Current	$V_{CE}=1200\text{V}, V_{GE}=0\text{V}, T_J=25^\circ\text{C}$			100	μA		
		$V_{CE}=1200\text{V}, V_{GE}=0\text{V}, T_J=150^\circ\text{C}$			10	mA		
I_{GES}	Gate Leakage Current	$V_{CE}=0\text{V}, V_{GE}=\pm 15\text{V}, T_J=25^\circ\text{C}$	-400		400	nA		
R_{gint}	Integrated Gate Resistor			7.5		Ω		
Q_g	Gate Charge	$V_{CE}=600\text{V}, I_C=100\text{A}, V_{GE}=15\text{V}$		0.5		μC		
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, V_{GE}=0\text{V}, f=1\text{MHz}$		14.5		nF		
C_{res}	Reverse Transfer Capacitance			140		pF		
$t_{d(on)}$	Turn on Delay Time	$V_{CC}=600\text{V}, I_C=100\text{A}$ $R_G=5\Omega$, $V_{GE}=\pm 15\text{V}$, Inductive Load	$T_J=25^\circ\text{C}$		300		ns	
			$T_J=125^\circ\text{C}$		310		ns	
			$T_J=150^\circ\text{C}$		310		ns	
t_r	Rise Time		$T_J=25^\circ\text{C}$		75		ns	
			$T_J=125^\circ\text{C}$		80		ns	
			$T_J=150^\circ\text{C}$		85		ns	
$t_{d(off)}$	Turn off Delay Time	$V_{CC}=600\text{V}, I_C=100\text{A}$ $R_G=5\Omega$, $V_{GE}=\pm 15\text{V}$, Inductive Load	$T_J=25^\circ\text{C}$		320		ns	
			$T_J=125^\circ\text{C}$		350		ns	
			$T_J=150^\circ\text{C}$		360		ns	
t_f	Fall Time		$T_J=25^\circ\text{C}$		80		ns	
			$T_J=125^\circ\text{C}$		150		ns	
			$T_J=150^\circ\text{C}$		160		ns	
E_{on}	Turn on Energy	$V_{CC}=600\text{V}, I_C=100\text{A}$ $R_G=5\Omega$, $V_{GE}=\pm 15\text{V}$, Inductive Load	$T_J=125^\circ\text{C}$		12		mJ	
			$T_J=150^\circ\text{C}$		13		mJ	
E_{off}	Turn off Energy		$T_J=125^\circ\text{C}$		9		mJ	
			$T_J=150^\circ\text{C}$		9.5		mJ	
I_{sc}	Short Circuit Current	$\text{tpsc} \leq 10\mu\text{s}, V_{GE}=15\text{V}$ $T_J=125^\circ\text{C}, V_{CC}=600\text{V}$			600		A	
R_{thJC}	Junction to Case Thermal Resistance (Per IGBT)				0.26	K/W		

Diode-inverter**ELECTRICAL CHARACTERISTICS ($T_C=25^\circ\text{C}$ unless otherwise specified)**

Symbol	Parameter/Test Conditions			Min.	Typ.	Max.	Unit
V_F	Forward Voltage	$I_F=100\text{A}, V_{GE}=0\text{V}, T_J=25^\circ\text{C}$		1.9	2.4	V	
		$I_F=100\text{A}, V_{GE}=0\text{V}, T_J=125^\circ\text{C}$		1.65			
		$I_F=100\text{A}, V_{GE}=0\text{V}, T_J=150^\circ\text{C}$		1.6			
t_{rr}	Reverse Recovery Time	$I_F=100\text{A}, V_R=600\text{V}$ $dI_F/dt=-1400\text{A}/\mu\text{s}$		300		ns	
I_{RRM}	Max. Reverse Recovery Current			120			A
Q_{RR}	Reverse Recovery Charge	$T_J=150^\circ\text{C}$		15.6		μC	
				6.2			μC
R_{thJCD}	Junction to Case Thermal Resistance (Per Diode)				0.4	K/W	

Diode-RECTIFIER**ABSOLUTE MAXIMUM RATINGS** ($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Values	Unit
V_{RRM}	Repetitive Reverse Voltage	$T_J=25^\circ\text{C}$	1600	V
I_{FRMS}	R.M.S. Forward Current Per Diode	$T_c=80^\circ\text{C}$	100	A
I_{RMS}	R.M.S. Current at rectifier output		150	
I_{FSM}	Non Repetitive Surge Forward Current	$T_J=45^\circ\text{C}, t=10\text{ms}, 50\text{Hz}$	1100	A
		$T_J=45^\circ\text{C}, t=8.3\text{ms}, 60\text{Hz}$	1210	
I^2t		$T_J=45^\circ\text{C}, t=10\text{ms}, 50\text{Hz}$	6050	A^2S
		$T_J=45^\circ\text{C}, t=8.3\text{ms}, 60\text{Hz}$	6076	

Diode-RECTIFIER**ELECTRICAL CHARACTERISTICS** ($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit
V_F	Forward Voltage	$I_F=100\text{A}, T_J=25^\circ\text{C}$		1.05		V
		$I_F=100\text{A}, T_J=150^\circ\text{C}$		1.05		V
I_R	Reverse Leakage Current	$V_R=1600\text{V}, T_J=25^\circ\text{C}$			50	μA
		$V_R=1600\text{V}, T_J=150^\circ\text{C}$			1	mA
R_{thJCD}	Junction to Case Thermal Resistance (Per Diode)				0.45	K /W

IGBT-Brake chopper**ABSOLUTE MAXIMUM RATINGS** ($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Values	Unit
V_{CES}	Collector Emitter Voltage	$T_J=25^\circ\text{C}$	1200	V
V_{GES}	Gate Emitter Voltage		± 20	
I_c	DC Collector Current	$T_c=25^\circ\text{C}$	115	A
		$T_c=100^\circ\text{C}$	75	
I_{CM}	Repetitive Peak Collector Current	$t_p=1\text{ms}$	150	
P_{tot}	Power Dissipation Per IGBT		440	W

Diode-Brake chopper**ABSOLUTE MAXIMUM RATINGS** ($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Values	Unit
V_{RRM}	Repetitive Reverse Voltage	$T_J=25^\circ\text{C}$	1200	V
$I_{F(AV)}$	Average Forward Current	$T_c=25^\circ\text{C}$	75	A
I_{FRM}	Repetitive Peak Forward Current		150	
I^2t		$T_J=125^\circ\text{C}, t=10\text{ms}, V_R=0\text{V}$	1800	A^2S

IGBT-Brake chopper
ELECTRICAL CHARACTERISTICS ($T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions			Min.	Typ.	Max.	Unit	
$V_{GE(th)}$	Gate Emitter Threshold Voltage	$V_{CE}=V_{GE}$, $I_C=3\text{mA}$		5.0	5.8	6.5	V	
$V_{CE(sat)}$	Collector - Emitter Saturation Voltage	$I_C=75\text{A}$, $V_{GE}=15\text{V}$, $T_J=25^\circ\text{C}$			1.85	2.3		
		$I_C=75\text{A}$, $V_{GE}=15\text{V}$, $T_J=125^\circ\text{C}$			2.15			
		$I_C=75\text{A}$, $V_{GE}=15\text{V}$, $T_J=150^\circ\text{C}$			2.25			
I_{CES}	Collector Leakage Current	$V_{CE}=1200\text{V}$, $V_{GE}=0\text{V}$, $T_J=25^\circ\text{C}$				100	μA	
		$V_{CE}=1200\text{V}$, $V_{GE}=0\text{V}$, $T_J=150^\circ\text{C}$				10	mA	
I_{GES}	Gate Leakage Current	$V_{CE}=0\text{V}$, $V_{GE}=\pm 15\text{V}$, $T_J=25^\circ\text{C}$		-400		400	nA	
R_{gint}	Integrated Gate Resistor				10		Ω	
Q_g	Gate Charge	$V_{CE}=600\text{V}$, $I_C=75\text{A}$, $V_{GE}=15\text{V}$			0.39		μC	
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}$, $V_{GE}=0\text{V}$, $f=1\text{MHz}$			11		nF	
C_{res}	Reverse Transfer Capacitance				100		pF	
$t_{d(on)}$	Turn on Delay Time	$V_{CC}=600\text{V}$, $I_C=75\text{A}$ $R_G=7.5\Omega$, $V_{GE}=\pm 15\text{V}$, Inductive Load	$T_J=25^\circ\text{C}$		300		ns	
			$T_J=125^\circ\text{C}$		310		ns	
			$T_J=150^\circ\text{C}$		310		ns	
t_r	Rise Time		$T_J=25^\circ\text{C}$		78		ns	
			$T_J=125^\circ\text{C}$		82		ns	
			$T_J=150^\circ\text{C}$		84		ns	
$t_{d(off)}$	Turn off Delay Time	$V_{CC}=600\text{V}$, $I_C=75\text{A}$ $R_G=7.5\Omega$, $V_{GE}=\pm 15\text{V}$, Inductive Load	$T_J=25^\circ\text{C}$		320		ns	
			$T_J=125^\circ\text{C}$		350		ns	
			$T_J=150^\circ\text{C}$		360		ns	
t_f	Fall Time		$T_J=25^\circ\text{C}$		80		ns	
			$T_J=125^\circ\text{C}$		150		ns	
			$T_J=150^\circ\text{C}$		160		ns	
E_{on}	Turn on Energy	$V_{CC}=600\text{V}$, $I_C=75\text{A}$ $R_G=7.5\Omega$, $V_{GE}=\pm 15\text{V}$, Inductive Load	$T_J=125^\circ\text{C}$		9.2		mJ	
			$T_J=150^\circ\text{C}$		10.1		mJ	
E_{off}	Turn off Energy		$T_J=125^\circ\text{C}$		6.7		mJ	
			$T_J=150^\circ\text{C}$		7.0		mJ	
I_{sc}	Short Circuit Current	$tpsc \leqslant 10\mu\text{S}$, $V_{GE}=15\text{V}$ $T_J=125^\circ\text{C}$, $V_{CC}=600\text{V}$			450		A	
R_{thJC}	Junction to Case Thermal Resistance (Per IGBT)					0.34	K/W	

IGBT-Brake chopper
ELECTRICAL CHARACTERISTICS ($T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions			Min.	Typ.	Max.	Unit	
V_F	Forward Voltage	$I_F=75\text{A}$, $V_{GE}=0\text{V}$, $T_J=25^\circ\text{C}$			1.9	2.4	V	
		$I_F=75\text{A}$, $V_{GE}=0\text{V}$, $T_J=125^\circ\text{C}$			1.65			
		$I_F=75\text{A}$, $V_{GE}=0\text{V}$, $T_J=150^\circ\text{C}$			1.6			
t_{rr}	Reverse Recovery Time	$I_F=75\text{A}$, $V_R=600\text{V}$ $di_F/dt=-1000\text{A}/\mu\text{s}$ $T_J=150^\circ\text{C}$			360		ns	
I_{RRM}	Max. Reverse Recovery Current				68		A	
					4.5		mJ	
R_{thJCD}	Junction to Case Thermal Resistance (Per Diode)					0.6	K/W	

NTC CHARACTERISTICS ($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit
R_{25}	Resistance	$T_c=25^\circ\text{C}$		5		$\text{k}\Omega$
$B_{25/50}$	$R_2 = R_{25} \exp [B_{25/50}(1/T_2 - 1/(298.15 \text{ K}))]$			3375		K

MODULE CHARACTERISTICS ($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions	Values	Unit
T_{Jmax}	Max. Junction Temperature	175	$^\circ\text{C}$
		150	
T_{Jop}	Operating Temperature	-40~150	
T_{stg}	Storage Temperature	-40~125	
V_{isol}	Isolation Breakdown Voltage	AC, 50Hz(R.M.S), t=1minute	V
CTI	Comparative Tracking Index	>200	
Md	Mounting Torque	Recommended (M5)	Nm
Weight		300	g

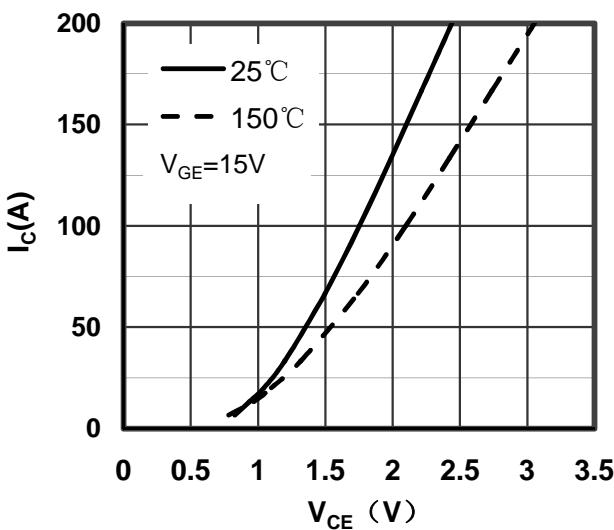


Figure 1. Typical Output Characteristics
IGBT-inverter

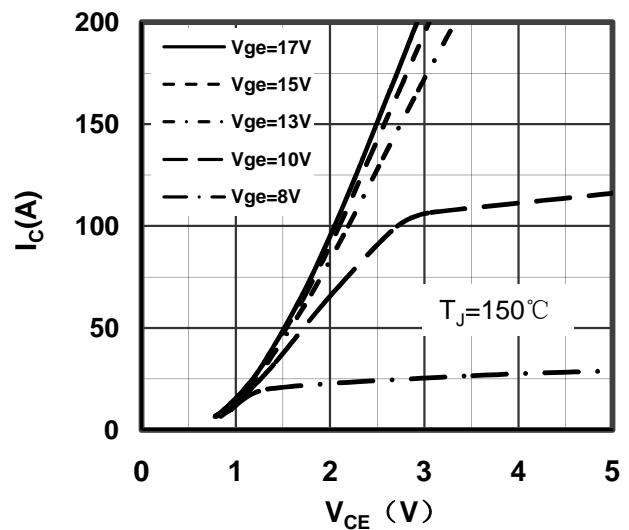


Figure 2. Typical Output Characteristics
IGBT-inverter

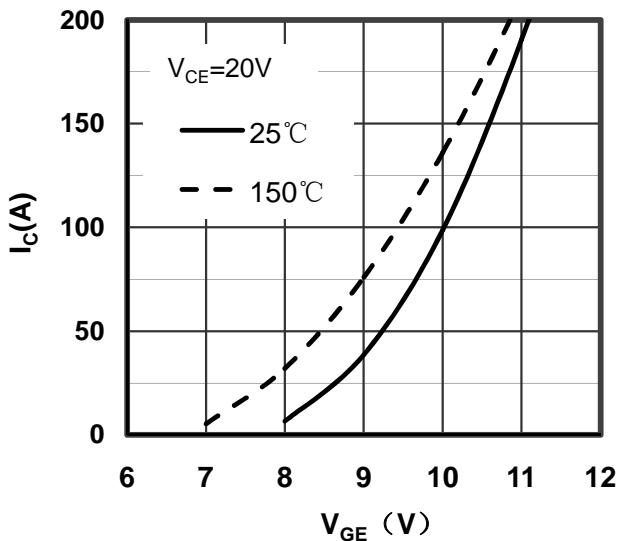


Figure 3. Typical Transfer Characteristics
IGBT-inverter

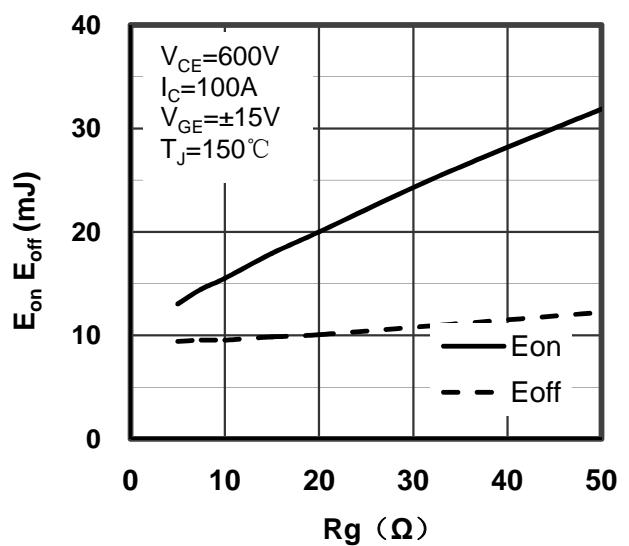


Figure 4. Switching Energy vs Gate Resistor
IGBT-inverter

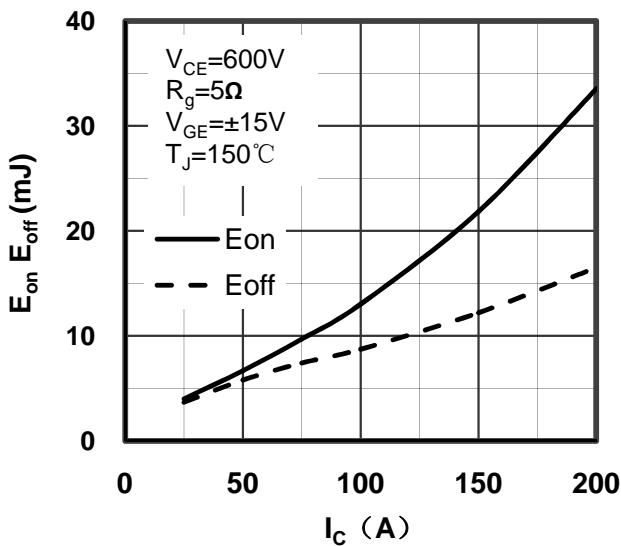


Figure 5. Switching Energy vs Collector Current
IGBT-inverter

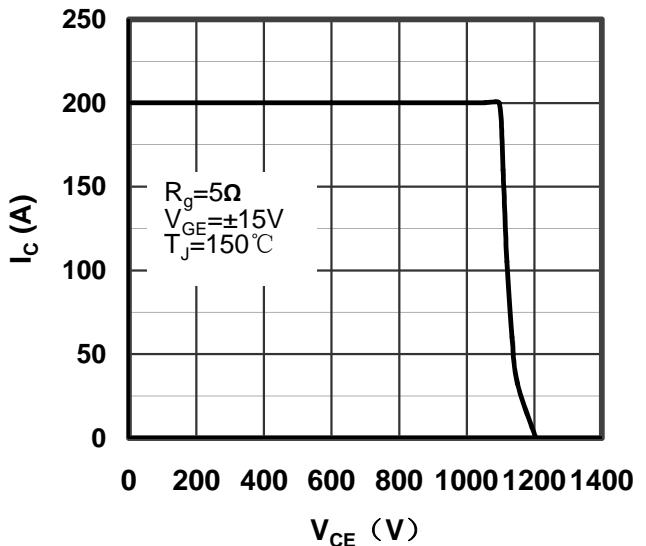


Figure 6. Reverse Biased Safe Operating Area
IGBT-inverter

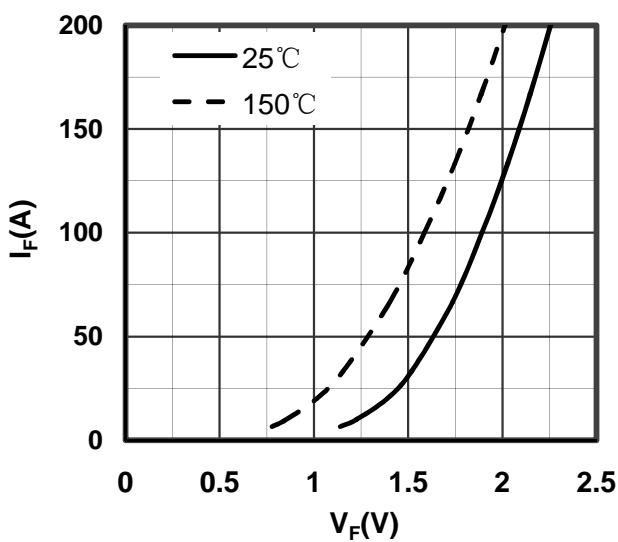


Figure 7. Diode Forward Characteristics
Diode -inverter

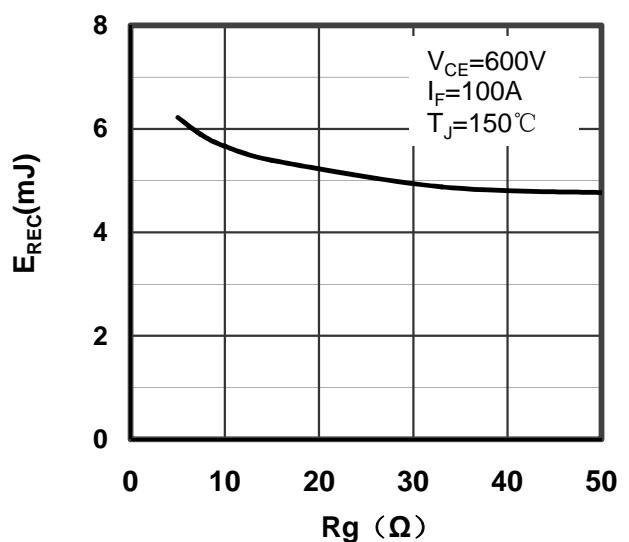
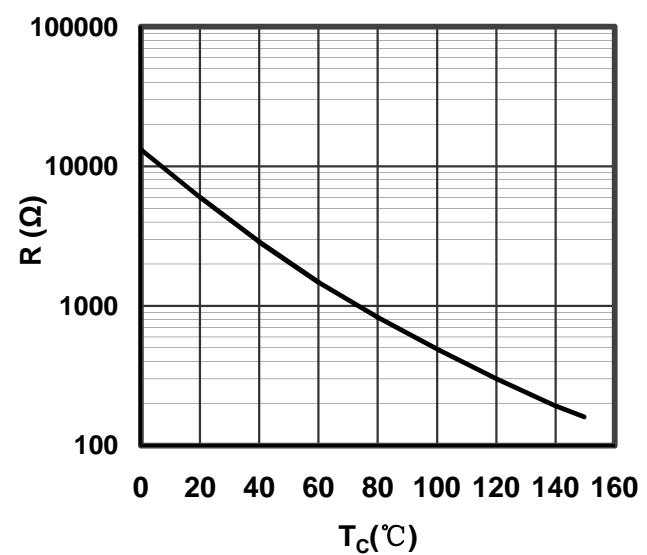
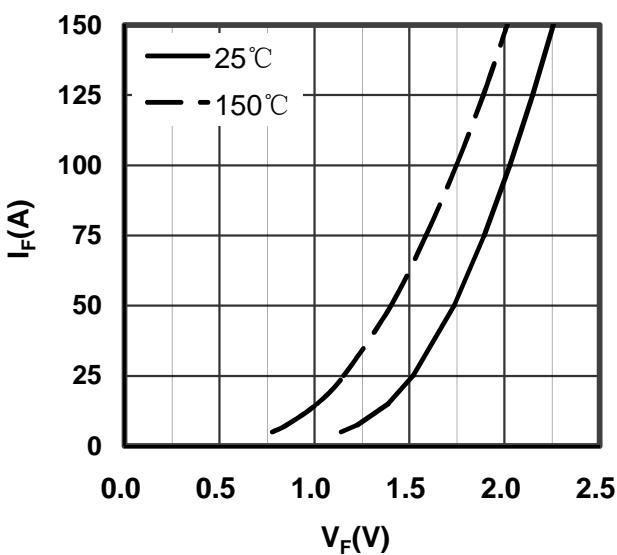
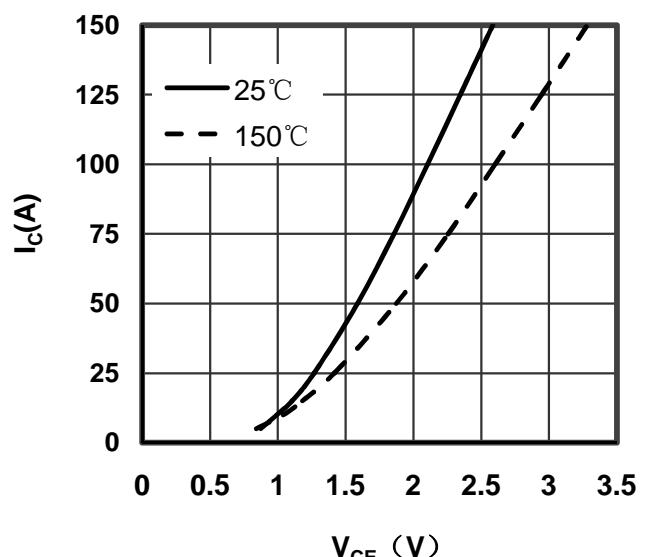
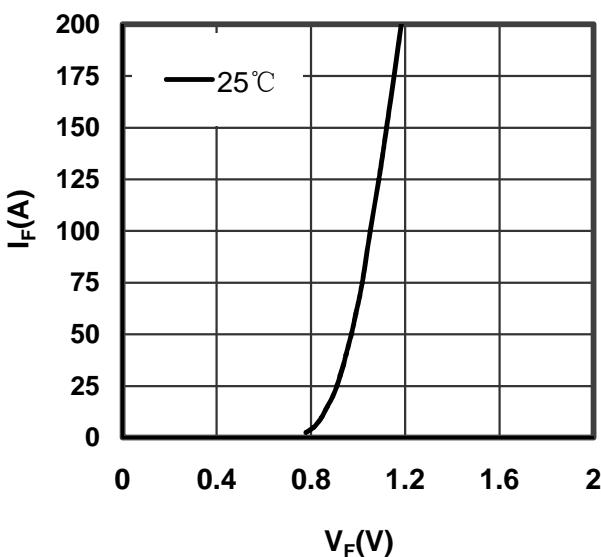
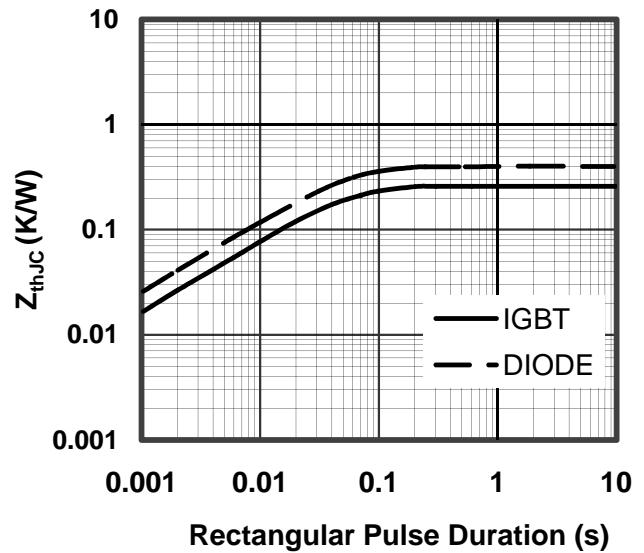
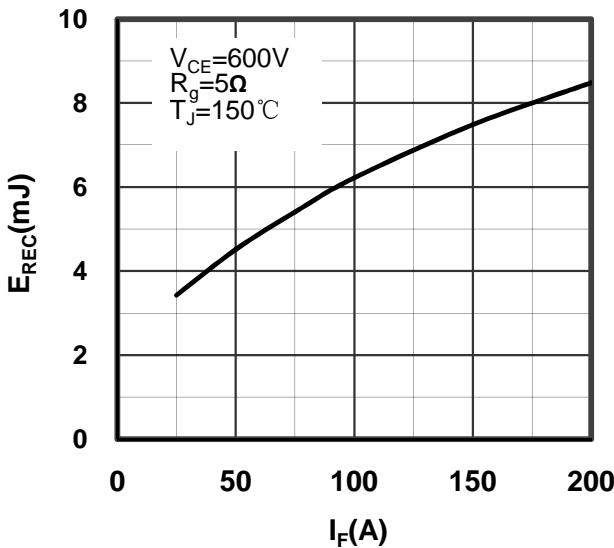


Figure 8. Switching Energy vs Gate Resistor
Diode -inverter



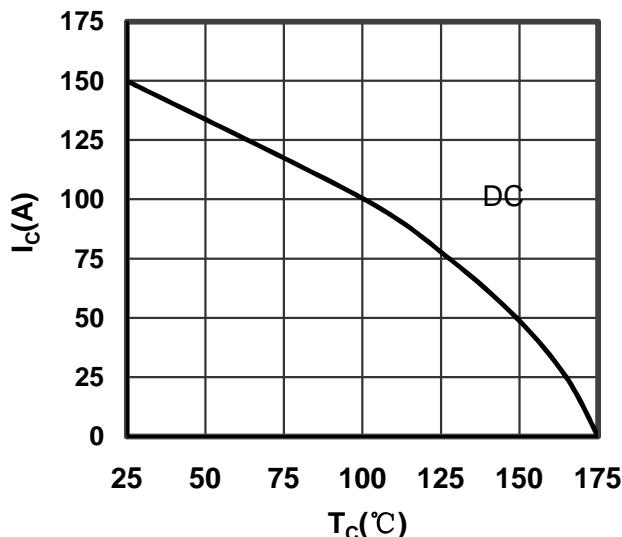


Figure 15. Collector Current vs Case temperature
IGBT -inverter

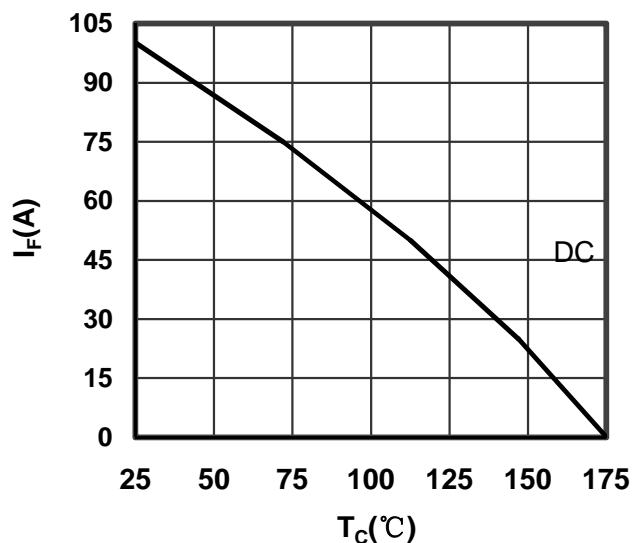


Figure 16. Forward current vs Case temperature
Diode -inverter

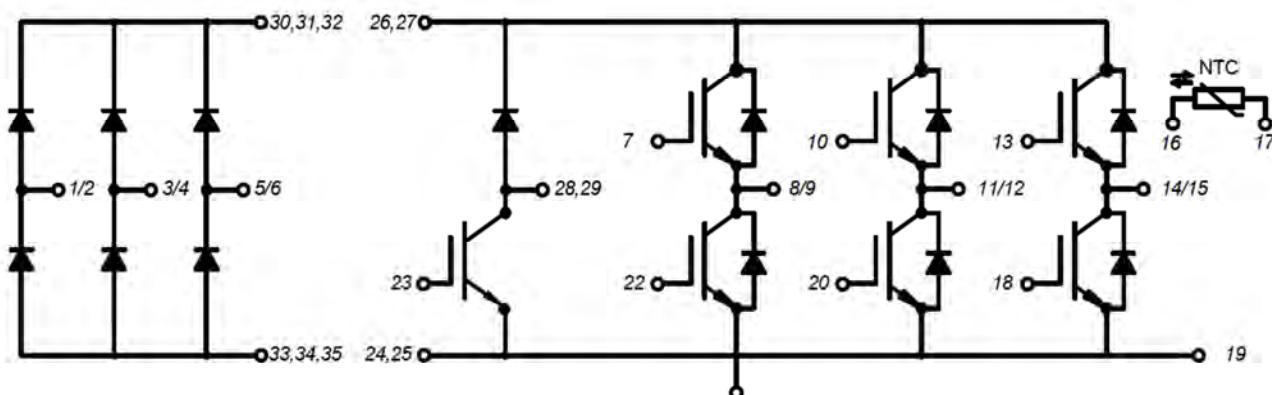
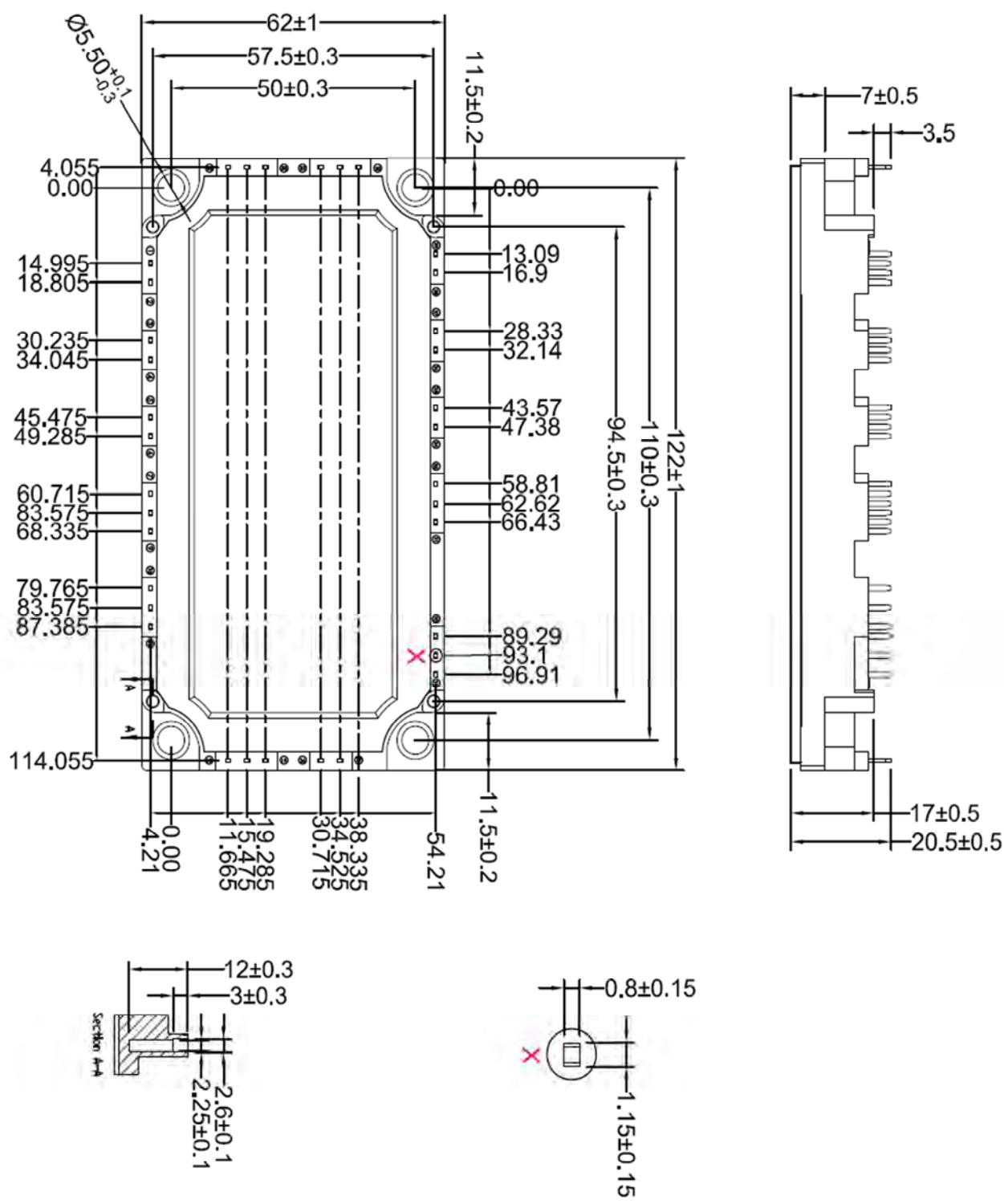


Figure 17. Circuit Diagram



Dimensions in (mm)
Figure 18. Package Outline